Notice of References Cited Application/Control No. | Applicant(s)/Patent Under Reexamination | VAN DER SANDEN ET AL. | Examiner | Art Unit | Matthew G. Kayrish | 2627 | Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-5,917,802	06-1999	Konno, Youichi	720/704
	В	US-			
	С	US-			
	D	US-			
	E	US-			
	F	US-		-	
	G	US-			
	Н	US-			
	1	US-			
	J	US-			
	K	US-			
	L	US-	-		
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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NON-PATENT DOCUMENTS

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*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)						
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